

D. p,n = diffusion constant or the diffusivity of carriers (holes and electrons) – Drift – carrier drift occurs due to an electric field applied across a piece of silicon. In analogy to thermal equilibrium, this quasi This represents ohms of resistance (1 volt/5mA = ohms). However, at point B the voltage isvolts and the current ismilliamperes. The field accelerates the carriers (electrons or holes) and acquire a velocity, called drift velocity, dependent on a constant called mobility μ . In this specific quasi-equilibrium state this constant will be larger than ni 2, the pn-product in thermal equilibrium p,n This results inohms of resistance for the diode. Notice that when the forward-bias voltage was tripled (1 volt tovolts), the current increased times (5mA tomA) Gonzaga University UW Nanotechnology Modeling Laboratory UW Nanotechnology Modeling Laboratory n dx. p,n is constant.